PH1955L

N-channel TrenchMOS logic level FET

Rev. 02 — 25 February 2009

Product data sheet

1. Product profile

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Suitable for logic level gate drive sources

1.3 Applications

12 V and 24 V loads

1.4 Quick reference data

DC-to-DC convertors

- Suitable for thermally demanding environments due to 175 °C rating
- General purpose power switching
- Motors, lamps and solenoids

Table 1.	Quick reference					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	55	V
I _D	drain current	$T_{mb} = 25 \text{ °C}; V_{GS} = 5 \text{ V};$ see <u>Figure 1</u> ; see <u>Figure 3</u>	-	-	40	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	75	W
Dynamic	characteristics					
Q_{GD}	gate-drain charge	V _{GS} = 5 V; I _D = 25 A; V _{DS} = 44 V; T _j = 25 °C; see <u>Figure 9</u>	-	8	-	nC
Static ch	aracteristics					
R _{DSon}	drain-source on-state resistance	$\label{eq:VGS} \begin{array}{l} V_{GS} = 10 \; V; \; I_D = 25 \; A; \\ T_j = 25 \; ^\circ C; \; see \; \underline{Figure \; 7}; \\ see \; \underline{Figure \; 8} \end{array}$	-	14.3	17.3	mΩ



2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		_
2	S	source	mb	
3	S	source		
4	G	gate	q;	
mb	D	mounting base; connected to drain	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	mbb076 S
			SOT669 (LFPAK)	

3. Ordering information

Table 3. Ordering information Type number Package Name Description Version PH1955L LFPAK plastic single-ended surface-mounted package (LFPAK); 4 leads SOT669

4. Limiting values

Table 4.Limiting values

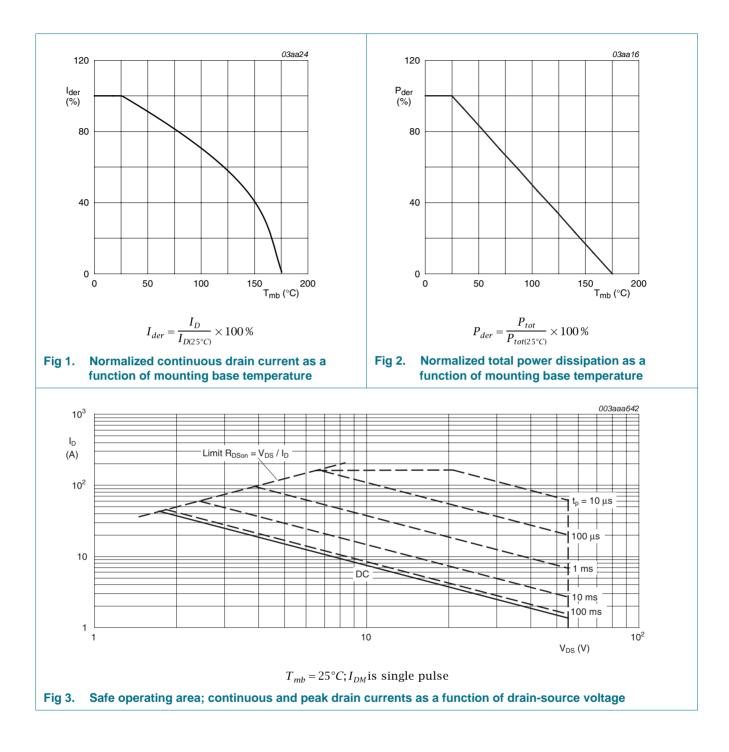
In accordance with the Absolute Maximum Rating System (IEC 60134).

• • •	n (A 11/1				
Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	55	V
V _{DGR}	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$		-	55	V
V _{GS}	gate-source voltage			-15	15	V
I _D	drain current	V_{GS} = 5 V; T_{mb} = 100 °C; see <u>Figure 1</u>		-	28	А
		$V_{GS} = 5 \text{ V}; T_{mb} = 25 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{\text{Figure 3}};$		-	40	A
I _{DM}	peak drain current	t _p ≤ 10 μs; pulsed; T _{mb} = 25 °C; see <u>Figure 3</u>		-	160	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	75	W
T _{stg}	storage temperature	age temperature		-55	175	°C
Tj	junction temperature			-55	175	°C
Source-dra	ain diode					
I _S	source current	T _{mb} = 25 °C		-	40	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	160	А
Avalanche	ruggedness					
E _{DS(AL)R}	repetitive drain-source avalanche energy	$\label{eq:VGS} \begin{array}{l} V_{GS} = 10 \text{ V}; \text{ I}_{D} = 4 \text{ A}; \text{ V}_{sup} \leq 55 \text{ V}; \text{ unclamped}; \\ t_{p} = 0.06 \text{ ms}; \text{ R}_{GS} = 50 \ \Omega; \end{array}$	[1][2]	-	0.8	mJ
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_{D} = 40 A; V_{sup} \leq 55 V; unclamped; t_{p} = 0.06 ms; R_{GS} = 50 Ω		-	80	mJ

[1] Duty cycle is limited by the maximum junction temperature.

[2] Repetitive avalanche failure is not determined simply by thermal effects. Repetitive avalanche transient should only be applied for short bursts, not every switching cycle.

PH1955L



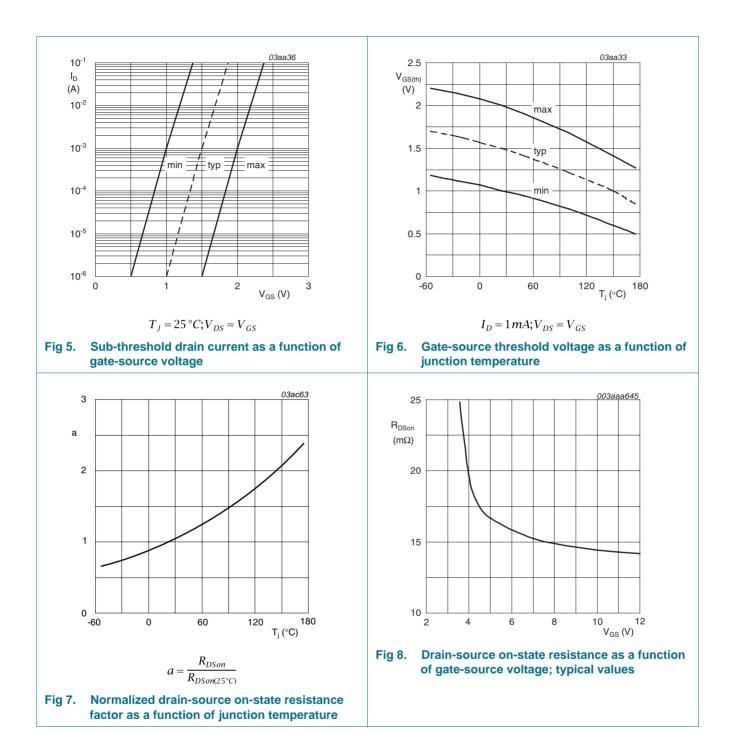
5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
₹ _{th(j-mb)}	thermal resistance from junction to mounting base	see <u>Figure 4</u>	-	•	2	K/W
10					003aaa643	
Z _{th(j-mb)} (K/W)						
1	δ = 0.5					
	0.2					
	0.05				t _p	
10 ⁻¹	0.02		F	°	$\delta = \frac{q}{T}$	
	single pulse					
10 ⁻²						
1	0 ⁻⁶ 10 ⁻⁵	10 ⁻⁴ 10 ⁻³ 10 ⁻²	10	r ⁻¹ t _p	, (s) 1	

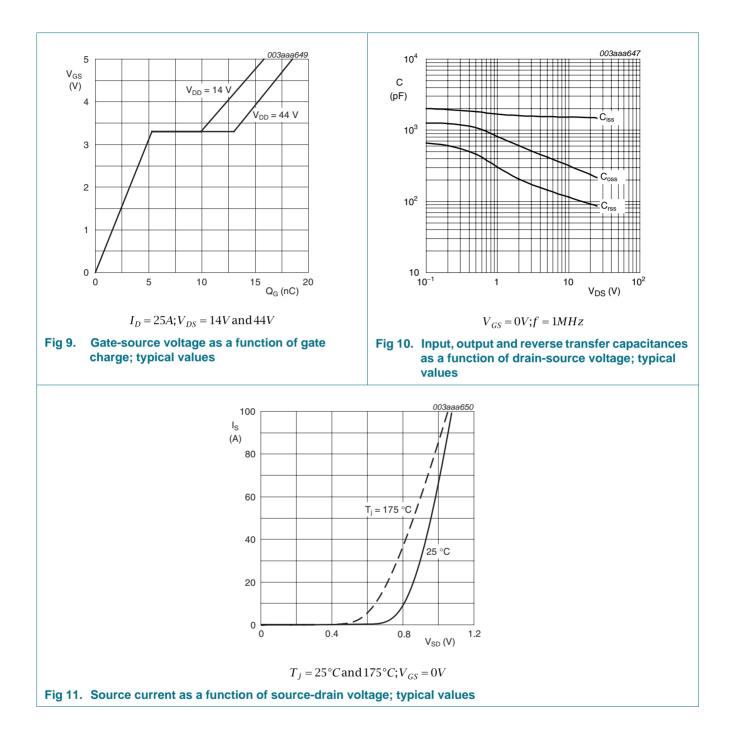
6. Characteristics

Table 6.	Characteristics							
Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
Static characteristics								
V _{(BR)DSS}	drain-source	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^\circ C$	50	-	-	V		
breakdown voltage		$I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^\circ\text{C}$	55	-	-	V		
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see <u>Figure 5</u> ; see <u>Figure 6</u>	0.5	-	-	V		
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 6</u> ; see <u>Figure 5</u>	1	1.5	2	V		
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = -55 °C; see <u>Figure 5</u> ; see <u>Figure 6</u>	-	-	2.3	V		
I _{DSS}	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	1	μA		
		$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μA		
I _{GSS}	gate leakage current	V_{GS} = 15 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA		
		$V_{GS} = -15 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA		
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 7</u> ; see <u>Figure 8</u>	-	14.3	17.3	mΩ		
		$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 175 \text{ °C};$ see <u>Figure 7</u> ; see <u>Figure 8</u>	-	-	40	mΩ		
		$V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 7</u> ; see <u>Figure 8</u>	-	-	21	mΩ		
		$V_{GS} = 5 \text{ V}; \text{ I}_D = 25 \text{ A}; \text{ T}_j = 25 \text{ °C};$ see Figure 7; see Figure 8	-	16.3	19	mΩ		
Dynamic	characteristics							
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 5 \text{ V};$	-	18	-	nC		
Q _{GS}	gate-source charge	T _j = 25 °C; see Figure 9	-	5	-	nC		
Q _{GD}	gate-drain charge		-	8	-	nC		
C _{iss}	input capacitance	V _{DS} = 25 V; V _{GS} = 0 V; f = 1 MHz;	-	1494	1992	pF		
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 10</u>	-	217	260	pF		
C _{rss}	reverse transfer capacitance		-	86	118	pF		
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 1.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$	-	18	-	ns		
t _r	rise time	$R_{G(ext)} = 10 \ \Omega; \ T_j = 25 \ ^{\circ}C$	-	180	-	ns		
t _{d(off)}	turn-off delay time		-	44	-	ns		
t _f	fall time		-	134	-	ns		
Source-d	rain diode							
V _{SD}	source-drain voltage	I _S = 25 A; V _{GS} = 0 V; T _j = 25 °C; see <u>Figure 11</u>	-	0.85	1.2	V		
t _{rr}	reverse recovery time	I _S = 20 A; dI _S /dt = -100 A/μs; V _{GS} = 0 V;	-	52	-	ns		
Q _r	recovered charge	V _{DS} = 30 V; T _j = 25 °C	-	38	-	nC		

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7. Package outline

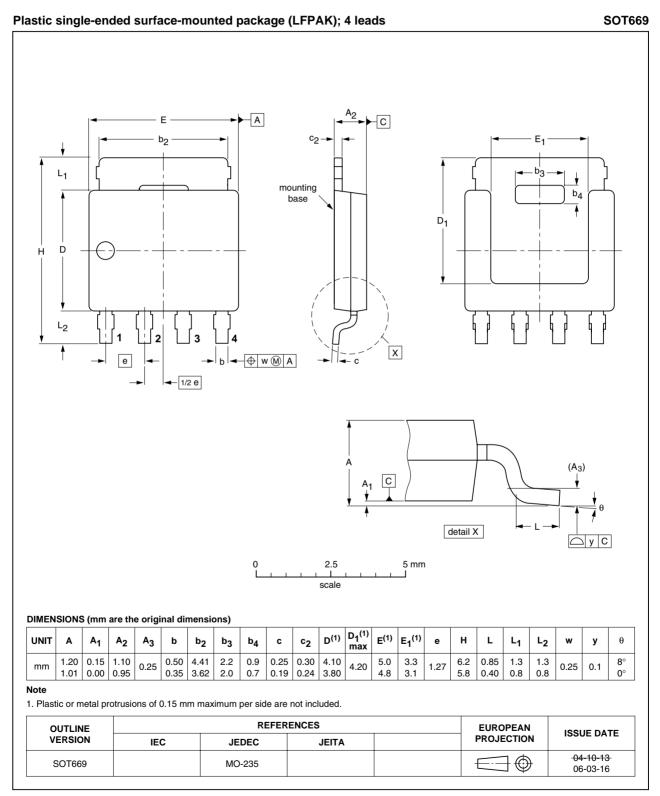


Fig 12. Package outline SOT669 (LFPAK)

8. Revision history

Table 7. Revision	history			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PH1955L_2	20090225	Product data sheet	-	PH1955L_1
Modifications:		of this data sheet has be of NXP Semiconductors.		ly with the new identity
	 Legal texts 	have been adapted to the	ne new company name v	where appropriate.
PH1955L_1	20050815	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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11. Contents

1	Product profile1
1.1	General description1
1.2	Features and benefits1
1.3	Applications1
1.4	Quick reference data1
2	Pinning information2
3	Ordering information2
4	Limiting values3
5	Thermal characteristics5
6	Characteristics6
7	Package outline9
8	Revision history10
9	Legal information11
9.1	Data sheet status11
9.2	Definitions
9.3	Disclaimers
9.4	Trademarks11
10	Contact information11

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